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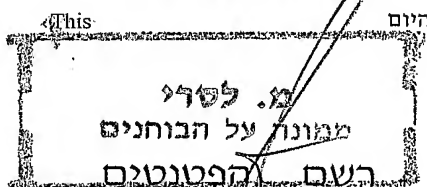
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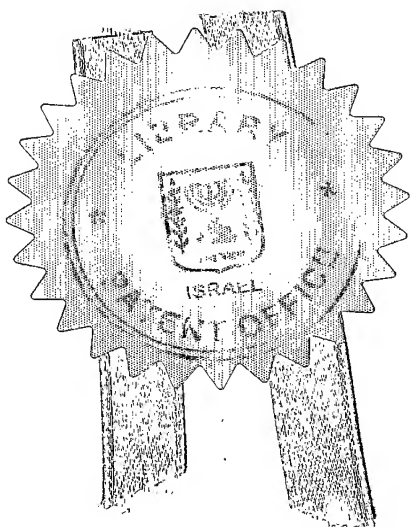
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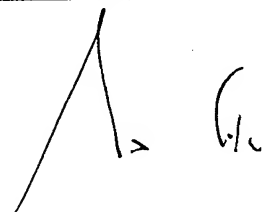
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בתוך נפח בעל עניין והתקן המיועד לכך

(באנגלית)
(English)

AN XRD MEANS FOR IDENTIFYING MATERIALS IN A VOLUME OF INTEREST
AND A METHOD THEREOF

הממציאים: אסף צוק, זאב הראל וזאב בורשטיין

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בתוך נפח בעל עניין ושיטה המיועדת לכך

AN XRD MEANS FOR IDENTIFYING MATERIALS IN A VOLUME OF
INTEREST AND A METHOD THEREOF

ממציאים:

אסף צוק

זאב הראל

זאב בורשטיין

FIELD OF THE INVENTION

The present invention generally relates to an XRD means and for identifying the content in a volume of interest and to a method thereof.

BACKGROUND OF THE INVENTION

Crystalline materials can be identified by their x-ray diffraction (XRD) pattern, which is unique to each material and can serve as its 'finger print'. Among the materials of security's sake interest are explosives, illegal drugs and spores (e.g. Anthrax spores). The patent suggests a remote detection method to identify suspected materials according to their XRD pattern. The suspected material in a Volume Of Interest (VOI), should be recognized by lower stage detection systems, such as: X-ray imaging system, Average density identification by multiple energy X-ray system, NMR (MRI), NQR, IR imaging, Millimetric Waves imaging, Terra-Hertz imaging, etc.

If monochromatic X-rays impinge upon a polycrystalline sample with randomly oriented crystallites, then some of the crystallites fulfill Bragg's law with respect to the x-ray beam. Thus, all reflections belonging to a particular lattice plane are distributed upon the mantle of a circular cone, of which the x-ray beam is the axis and the aperture angle is 4θ . An x-ray sensitive film or an X-ray detector placed perpendicularly to the x-ray beam will thus record concentric circles as diffraction image. The Bragg's angle is given by equation (1):

$$\theta = \frac{1}{2} \arctan \frac{D}{2x} \quad (1)$$

wherein the diameter of a diffraction ring is D, and x is the distance between the sample and the film.

A variety of X-ray detectors were presented in the art. Digital X-ray recording comprised of the steps of capturing X-ray photons and converting the recorded signal to an electrical signal. These systems are intrinsically pixilated to form either a pixilated array or a continues array with a moving "pixellated-bridge" ("pixilated-

bridge" means one-dimensional or very narrow two-dimensional scanning pixel array). The detectors may be divided into two main groups, namely direct and indirect detectors. Direct detectors use photo-conducting material such as Silicon, Germanium, Selenium, CdTe, CdZnTe, PbI₂ or HgI₂, and are adapted for directly converting x-ray energy into electric charge utilizing TFT (Thin Film Transistor), CMOS (Complementary Metal-Oxide Semiconductor) technology or any other type of substrate whether continuous or pixellated array. This charge can be then captured, stored and recorded. Indirect detectors use scintillator material such as NaI, CsI or Gd₂O₂S, to convert the x-ray energy into light, which must be optically coupled to a photosensitive device, e.g. photo-diodes array or CCD (Charge Coupled Device). This photo sensor then converts the light into electric charge, which can be captured, stored and recorded.

Indirect conversion is a two steps process wherein X-rays are first converted by a means of a scintillator or phosphor material to lower energy photons, e.g. visible light photons that are being collected and converted into an electric charge. Commercial available products of GE Medical Equipment Inc. comprising amorphous silicon flat panel with Cesium Iodide scintillator is an example for such a technique.

Direct conversion is single conversion step process. At least three types are known in the art: TFT, CMOS and Continuous plates. The TFT is coated by a photoconductor, wherein the detector uses a direct conversion of x-ray energy into electrical signals. No light-emitting materials, intermediate steps and/or additional processes are required to capture and convert the incident x-ray energy. The commercially available products of Hologic Inc. are example for this type, wherein Amorphous Selenium photoconductor is used. Continuous plates are scanned by means of a moving pixellated-bridge. A selenium-based sensor is used to convert incident X-rays into an electric charge image. The charge image is transformed into a digital image using this bridge, which eliminates the costly and often-problematic active matrix arrays. The commercially available products of Edge Medical Devices Ltd. and its Scanned Matrix Array Readout Technology (SMART) is utilizing this technology,

US Pat. No. 2001/0033636 to Hartick *et al.* discloses a method and apparatus for determining a material of a detected item and deals with a specific method of defining

a VOI by means of calculating the average density of the detected volume and a correlation between the VOI and the XRD shots.

US Pat. No. 2003/0169843 to Ries *et al.* presents a method and an apparatus for detecting unacceptable items in objects, such as in luggage, wherein a detector apparatus, functioning as a second detector stage is divided into a lower testing stage and a higher testing stage. This invention deals with a specific energy dispersion method of XRD.

BRIEF DESCRIPTION OF THE INVENTION

In order to understand the invention and to see how it may be implemented in practice, a plurality of embodiments will now be described, by way of non-limiting example only, with reference to the accompanying drawing, in which

figure 1 schematically presents a plurality of typical diffraction rings pattern, also known as "Debye-Scherrer" pattern, in a view comprising only the middle portion of the ring; a diffraction characterized by a set of three 4θ s is presented (right hand view); a back-diffraction characterized by a set of three $360^\circ - 4\theta$ is also presented (left hand view);

figure 2 schematically presents a remote XRD means for identifying the content of the volume of interest (VOI) according to one embodiment of the present invention;

figure 3 schematically presents a remote XRD means for identifying the content of the VOI according to yet another embodiment of the present invention;

figure 4 schematically presents a remote XRD means for identifying the content of the VOI according to yet another embodiment of the present invention;

figure 5 schematically presents a remote XRD means for identifying the content of the VOI according to yet another embodiment of the present invention;

figure 6 schematically presents remote back-scattered XRD means for identifying the materials located in the VOI according to yet another embodiment of the present invention;

figure 7 schematically presents a method for identifying materials located in the VOI according to one embodiment of the present invention;

figure 8 schematically presents a method for identifying materials located in the VOI according to yet another embodiment of the present invention;

figure 9 schematically presents a method for identifying materials located in the VOI according to yet another embodiment of the present invention;

figure 10 schematically presents a Cell-X detector according to yet another embodiment of the present invention

SUMMARY OF THE INVENTION

It is thus one object of the present invention to provide a useful remote XRD means for identifying the materials located in a volume of interest (VOI). Said means are comprised of a plurality of N X-ray sources targeted towards said VOI adapted to emit a well characterized X-ray beam towards the target; wherein N is an integer number equal or higher 1; a plurality of M two dimensional (2D) X-ray detectors adapted to receive diffracted X-rays so an image comprising at least a portion of the obtained XRD patterns is obtained; wherein M is an integer number equal or higher 1; a processor adapted to measure said patterns; a database comprising records of patterns' parameters characterizing predetermined material; said database comprising records of materials that a notification should be provided when identified; and an alerting means adapted to alert wherein the identified material in the VOI is one of said predetermined groups. This means is potentially adapted to identify sampled moving VOIs in a non-intruding manner. It may further comprised of suitable means to sample the material in the VOI so the presence of the material is notified; and means to surveillance or follow up said VOI before identifying its nature. Those remote XRD means are preferably adapted to alert either online or offline, to alert to a

predetermined remote location, to be in communication with effective means adapted to isolate or immobilize said VOI transport until subsequent notification or any combination thereof.

It is acknowledged in this respect that one X-ray source may be providing for a continuous radiation, or plurality of shots, in singular or plurality of directions. Hence a single 2D X-ray detector may be synchronized to detect each shot in a way that it is centered and relocated at a perpendicular position to the beam or a plurality of 2D X-ray detectors, which are synchronized, with the diffracted X-rays.

It is another object of the present invention to provide a method for acquiring an XRD pattern of a material inside a VOI. This method is comprised the steps of receiving VOI coordinates from lower stage system; irradiating the material in the VOI; acquiring of XRD patterns; extracting of VOI's XRD patterns; converting the XRD patterns of said material to standard powder X-ray diffraction spectrum; searching and/or matching records in a database for material identification; and then, alerting in case said material is in matching a predetermined record. It is well in the scope of the present invention wherein this method is provided by the means as defined in any of the above; wherein back scattering is obtained and/or wherein energy information is collected in addition to the imaging calculations via the use of Cell-X detector or Gamma Camera-like devices.

DETAILED DESCRIPTION OF THE INVENTION

The following description is provided, alongside all chapters of the present invention, so as to enable any person skilled in the art to make use of said invention and sets forth the best modes contemplated by the inventor of carrying out this invention. Various modifications, however, will remain apparent to those skilled in the art, since the generic principles of the present invention have been defined specifically to provide a remote process for identifying hazardous materials such as explosives in a VOI by means of a XRD based system.

It is the object of the present invention to provide a secure, reliable and rapid system for enabling a remote detection of hazardous materials and thus to provide for

passengers and/or their carry-on luggage to walk in a reasonably wide corridor while being examined by the system without being intruded.

The term 'materials in a volume of interest' is related to hazardous materials, such as explosives, flammable, toxic, chemical and biological warfare substances in either gas, liquid or solid states, drugs and narcotics, radioactive agents etc., and to metallic materials, such as iron, gold, platinum and any other valuable crystalline materials (e.g. ceramics, polymeric materials), which are suitable for XRD analysis. The VOI is hence denoted according to the present invention to any 3D capacity to be analyzed.

According to one embodiment of the present invention, those materials are related to any of the hereto-defined hazardous or crystalline materials, being transferred on a passenger and/or in his carry-on luggage, especially in airports and similar locations. According to one specific embodiment of the present invention, said material is selected from any explosive materials. According to yet another specific embodiment of the present invention, said material is selected from any chemical or biological warfare.

It is in the scope of the present invention wherein the material in the VOI is located, analyzed, identified, and marked by any means, such as X-ray Imaging system, average density identification by Multiple Energy X-ray system, NMR (Nuclear Magnetic Resonance) (MRI – Nuclear Magnetic Resonance Imaging), NQR (Nuclear Quadruple Resonance), IR imaging, Millimetric Waves imaging, Terra-Hertz imaging, etc.) at a first step, and then said material is further analyzed by the remote XRD means as defined and described in the present invention. The surveillance and follow-up after the VOI identified at the first step may be provided by various video techniques or other means adapted for online image processing, whereat said VOI is transferred along a predetermined course, on a conveyor belt etc. and especially whereat said VOI is transferred along a non-predetermined course (e.g., incidental move of a passenger with his carry-on luggage in a corridor).

It is in the scope of the present invention wherein said material in the VOI is a subject of imaging by a system comprising a combination of a singular or plurality of X-ray sources and a singular or plurality of X-rays detectors. Additionally or alternatively, said VOI is a subject of a continues irradiation or a sequence of subsequent X-ray

shots taken by the aforementioned complex system, so a reliable and rapid analyzes are provided.

The term 'XRD' is referring to method for determining the nature of a sample by calculating its diffraction pattern in either scattered or back-scattered techniques. More over, the term XRD is also referring to any scattering or back-scattering system and/or to an incorporated system comprising XRD or back-scattered XRD with analyzing means adapted for energy or energetic detection, such as a detector array system which is providing energy characteristics of the material in the VOI, or a combination of the detectors array which is providing a simultaneous energy and position characteristics of the diffraction pattern of the material in the VOI.

The system basically consists of collimated X-ray source synchronized with 2D detector array. The X-ray source provides a narrow collimated beam that passes through the VOI. The X-rays are diffracted from the sampled material (and its neighbor materials which are in the X-ray beam path). The diffracted pattern is recorded by linear or two-dimensional array. Image processing is applied in order to define the number, diameter, intensity and broadening of the XRD patterns (e.g. the Debye-Scherrer rings). The XRD patterns are converted to standard powder XRD patterns and existing or proprietary search/match utilities or software (such as the commercial available Rietveld based software) can be used to identify the material.

Reference is made now to figure 1, schematically presenting a plurality of Debye-Scherrer rings in a narrowed view, which comprised of the central portion of the ring. This diffraction is characterized by a set of three 40s patterns around the primary beam exit hole (1) (See 2 for example). Adjacent to the left side of the presentation, a back-diffraction is provided, wherein the insert hole of the primary beam (3) is surrounded by a set of three 360°-40s pattern (See 4 for example).

Reference is made now to figure 2, schematically presenting one embodiment of the present invention wherein a plurality of XRD patterns (1-3) are located at various spatial positions are acquired by one X-ray source and one mechanically synchronized 2D detector. Here, one X-ray source (e.g., an X-ray generator) is synchronized with a detecting plate in a way that the beam passes through the VOI. The X-ray generator is being moved between pluralities of predetermined locations, and the location of the

detecting plate is synchronized with it, in such a way that the X-ray beam path through the VOI and the detecting plate is located along the beam while being perpendicular to it. The process repeats itself for the improvement of the detection rate. The x-ray source (21) is producing sufficient amount of X-rays, which potentially processed by a means of a collimator (22) before said processed X-rays (23) reach the VOI (24) accommodated in a container (25). According to the present invention, such an X-ray producing means (20) is comprised of a X-ray source (21), a collimator (22) or any other means adapted to process the produced X-ray provided for an effective X-ray beam (e.g. a focusing element). The diffracted X-rays are being obtained by a means of at least one two dimensional detector (26) so a measurable plurality of XRD patterns (27) is obtained. Locations (1-3) are the positions of the x-ray source wherein (1', 2', 3') are the relative positions of the aforementioned 2D detector (26).

Reference is made now to figure 3, schematically presenting a moving VOI, e.g., an object being transferred or a passenger walking with his carry-on-luggage, whereat a plurality of X-ray beams are emitted in the manner the beams are synchronized with the X-ray detectors. Fig. 3 is thus schematically presenting a novel non-intruding system (30) according to yet another embodiment of the present invention, which is especially adapted for obtaining multiple X-ray diffractions. This system (30) is especially useful for analyzing moving VOIs, and is comprised of an X-ray source, such as source (31), which is adapted to emit X-rays over a VOI (33) being moved along a corridor (32) in the direction (D). The X-ray source (31) is emitting a beam (A) over the sample located in site 34, so the diffraction is recorded by the 2D detector 37A; and a plurality of other beams directed to another one or more predetermined angles and directions, synchronized with the new location of the VOI at each particular time. For example, source (31) is directing its beams in the manner that the VOI is sampled in its way (D) on conveyer (32), namely at locations 35 and 36, by beams B and C, so diffractions B' and C' are provided on 2D detectors 37B and 37C, respectively.

Reference is made now to figure 4, schematically presenting another embodiment of the present invention, wherein the system is adapted to obtained a plurality of XRD pattern images on one 2D detector from plurality of x-ray beams. Fig. 4 hence illustrates a system wherein a plurality of shots are taken by either plurality of X-ray

generators or one moving X-ray generator; wherein all the XRD patterns are detected on one big detecting plate. Each shot is being taken in a way that the beam passes through the VOI. Here for example, three X-ray sources are provided, 41A-C. Each source is comprised of an X-ray source and a collimator or any equivalent device (42A-C). Hence, three X-ray beams (43A-C) are directed towards the VOI (44) located in a container (45). Each beam is targeting a predetermined portion at the 2D detector (46), in the manner that three XRD patterns (47A-C, respectively) are obtained.

Reference is made now to figure 5, schematically presenting another embodiment of the present invention, adapted to obtain a multiple XRD patterns simultaneously using from a plurality of X-ray beams and a plurality 2D detectors. Here, a plurality of X-ray sources (e.g., X-ray generators) are targeted towards identical number of X-ray detectors (e.g., detecting plates) while each of them is synchronized to penetrate the VOI. It is acknowledged in this respect that any number X-rays sources and detectors are applicable at a variety of combinations, and sources to detectors ratios are possible. Here, three X-ray sources (51A-C) are hereto presented. Each source is comprised of an X-ray source and a collimator or any equivalent device (52A-C). Hence, three X-ray beams (53A-C) are directed towards the VOI (54) accommodated in a container (55). Each XRD provided by said three beams is targeting a predetermined 2D detector (56A-C).

Reference is made now to figure 6, schematically presenting according to yet another embodiment of the present invention, a system (60) that is adapted to obtain at least one back-scattered XRD. The X-ray source (61) is generating at least one beam (63) targeted towards the sample in the VOI (64) in a container (65) in the manner that a back-scattered beam (67) is recorded on a 2D detector (66). It is further acknowledged that system (60) may be used simultaneously with one or more other back-scattering systems and/or with one or more systems as defined and described above, such as aforementioned systems 20, 30, 40, 50 etc.

It is the object of the present invention to provide a useful and remote method for identifying the content of a VOI. It is thus according to yet another embodiment of the present invention wherein the aforementioned process is comprised of the general following steps:

- i. receiving of VOI coordinates from lower stage system;
- ii. irradiating the material in said VOI by one or plurality collimated X-ray beam(s);
- iii. acquiring of XRD pattern results from each impinging X-ray beam;
- iv. extracting of XRD pattern of material;
- v. converting the ring XRD pattern of the material to standard powder X-ray diffraction spectrum (Intensity against two Theta);
- vi. searching and/or matching data base for material identification (e.g. according to the Rietveld method); and then,
- vii. alerting (Y/N).

Reference is made now to figure 7 presenting a schematic flow chart of another embodiment of the present invention; wherein in step (71) an information concerning the VOI, i.e., an X, Y & Z information, is obtained by a prior step of allocating the VOI (not shown here). The collimated X-ray beam is targeted towards the center of the VOI.

A set of images of XRD pattern or patterns (i.e., rings) of the VOI obtained by 2D detector array is acquired at step (72). Now at step (73), a plurality of calculations on each image is provided to complete missing or unclear arcs in the ring shape. Step (74) is comprised of the application of subtraction calculation or any other image processing calculations adapted to find the common XRD pattern of said VOI as appears in set of all images. At the following step (75), the center of broadening of the ring line is determined, especially for thick or (spreaded) blurred lines. In some cases, the entire ring pattern may not be revealed, but rather a part of it. It is possible to find the required data from a part of the ring only. Also, calculations on the average perimeter of the ring will allow higher reliability. Subsequently at step (76), the ring diameter is determined, in the manner that ring intensity and ring broadening of the extracted VOI pattern is obtained. At step (77) the ring pattern is being converted to powder XRD spectrum. Then, at step (78), matching the obtained XRD pattern with known materials in database is provided, wherein at case of matching, the VOI is positively identified. It is acknowledged in this respect that when hazardous materials are identified, an effective inline or offline alert is provided (78A). If such a matching is not provided (78B), general alert or a specific notification is provided, and the aforementioned process is repeated in the manner that a plurality of XRD images and/or other analytical characterizations are subsequently taken from different angles.

In the case that after N states, wherein N is an integer number higher one, the system has not absolutely identify the material as hazardous, but a possibility for the existence of such material do exists, than a special alert will be given to the operator.

It is acknowledged in this respect that the term 'alarm' according to the present invention is referring to any notification given to either a remote site or to the operator located adjacent to the system. The alert is selected in a non limiting manner from alarm, applicable especially wherein hazardous materials detected in the VOI; appeasing notification, especially applicable wherein non-hazardous materials are comprised in the detected VOI and/or wherein the VOI is analyzed to be non hazardous; and notification per se; applicable especially wherein the system is operated in a specific mode of recording the nature/composition of goods and/or materials passing throughout a predetermined path.

Reference is made now to figure 8 presenting a schematic flow chart of another embodiment of the present invention; wherein in step (81) a VOI information, i.e., an X, Y & Z information is obtained by a prior step of allocating the VOI (not shown here). During the examining, a sub-system tracks the VOI, and supplies its (changed) coordinates when required. The collimated X-ray beam is targeted towards the center of the VOI. A set of images of XRD pattern or patterns (e.g., rings) of the VOI obtained by 2D detector array is acquired at step (82). Now at step (83), a plurality of calculations on each image is provided to complete missing or unclear arcs in the ring shape. Step (84) is comprised of the application of subtraction calculation, adapted to find the common XRD pattern of said VOI as appears in set of all images. At the following step (85), the center of the ring line is determined, especially for thick or spreaded lines. Subsequently at step (86), the ring diameter is determined, in the manner that ring intensity and ring broadening of the extracted VOI pattern is obtained. At step (87) the ring pattern is being converted to powder XRD spectrum. Then, at step (88), matching the obtained XRD pattern with known materials in database is provided, wherein at case of matching, the material in the VOI is positively identified (hazardous material is identified) the alert is provided (88A). If such a matching is not provided, the aforementioned process is repeated (88B). In the manner that a plurality of XRD images or other analytical characterizations are subsequently taken from different angles regarding the moving target. The new VOI coordinates are supplied to the system from a tracking sub-system (89). In the case

that after N states, wherein N is an integer number higher one, the system has not absolutely identify the material as hazardous, but a possibility for the existence of such material do exists, than a special alert will be given to the operator.

Reference is made now to figure 9 presenting a schematic flow chart of yet another embodiment of the present invention; wherein in step (91) a VOI information, i.e., an X, Y & Z information is obtained by a prior step of allocating the VOI (not shown here). A plurality (e.g., three) of collimated X-ray beams are targeted towards the center of the VOI, where each X-ray generator is located at a different location. A set of images of a complex XRD pattern or patterns (e.g., rings) of the material in the VOI obtained by 2D detector array is acquired at step (92). Now at step (93), a plurality of calculations on each pattern is provided to complete missing or unclear arcs in the ring shape. Step (94) is comprised of the application of subtraction calculation, adapted to find the common XRD pattern of said VOI as appears in set of all images. At the following step (95), the center of the ring line is determined, especially for thick or spreaded lines. Subsequently at step (96), the ring diameter is determined, taking into account the ellipsoid shape of some of the patterns, in the manner that ring intensity and ring broadening of the extracted material pattern is obtained. At step (97) the ring pattern is being converted to powder XRD spectrum. Then, at step (98), matching the obtained XRD pattern with known materials in database is provided, wherein at case of matching, the material is positively identified (when an hazardous material is identified the alert is provided) (98A). If such a matching is not provided, alert is provided, and the aforementioned process is repeated (98B) in the manner that a plurality of images or any other analytical characterizations are subsequently taken using the different angles sources regarding the moving target. In the case that after N states, wherein N is an integer number higher one, the system has not absolutely identify the material as hazardous, but a possibility for the existence of such material do exists, than a special alert will be given to the operator.

Reference is made now to figure 10 presenting a novel multi-functional detectors array adapted for a flexible cellular-XRD technology (100), according to yet another embodiment of the present invention, denoted hereinafter in the term 'Cell-X'. The technology is especially useful for a remote detection of explosive materials, and is based on incorporating XRD pattern imaging with acquiring energy information. The

detector is comprised of two general ingredients: imaging detectors (101), and an energy means (spectrometer detector) (102), much similar to those known in the art. Those commercially available means are adapted for the detection of the XRD patterns (e.g., Debye-Scherrer rings) on a 2D pixel array detector. According to a more specific embodiment of the present invention, which is described in figure 10, each "unit cell" consists of 2D array detector surrounded by a plurality of stripes of one-dimensional or very narrow (very thin) two-dimensional array of detector elements having energy resolution (spectroscopy abilities), such as stripes of solid state single crystal detectors, stripes of high-quality polycrystalline detectors, stripes of scintillation detectors etc. The Cell-X is comprised of small, medium, large unit cells or any combination thereof. According to one embodiment of the present invention, the size of the Cell-X is approximately a human-being size (80cm X 220 cm), which is enabling XRD examinations of a passenger entering the gates-area of an airport when walking with his carry on luggage. Cell-X is providing imaging information, while simultaneously is providing energy information, so XRD patterns are recognized as part of the imaging while energy information can be collected from each spectroscopy detector element (pixel) crossed by an XRD pattern.

The "flexibility" of the Cell-X is in its cells sizes and ratio between the imaging arrays and the spectroscopy linear arrays (stripes). It may vary from very large imaging arrays surrounded by spectroscopy stripes, through small imaging arrays surrounded by verity of thickness spectroscopy arrays, and up to a unit in which the size of each imaging array will be zero thus the actual spectroscopy array will be the whole array detector. This Cell-X array which is entirely structured of spectroscopy array may serve as a Gamma Camera, but for our remote detection needs it will work as follows:

- (i) the array has now a dual capability (imaging and spectroscopy) all over the array;
- (ii) the whole array will serve as an imaging array, and will work like any of the above mentioned imaging arrays; and,
- (iii) the whole array will serve as a spectroscopy array.

Certain pixels, which are located on the XRD patterns, will be analyzed for energy information, in order to upscale the recognition quality and to speed up the recognition process. It should be noted that the number and the location of each pixel to be energetically analyzed may vary from a predetermined location of each sampled

pixel and the number pixels and up to a coincidence number of pixels to be sampled and their location.

CLAIMS

1. A remote XRD means for identifying a material in a volume of interest (VOI) comprising;
 - a. a plurality of N X-ray sources targeted towards said VOI; wherein N is an integer number equal or higher 1;
 - b. a plurality of M X-ray detectors adapted to receive diffracted X-rays so an image comprising at least a portion of the obtained XRD patterns is obtained; wherein M is an integer number equal or higher 1;
 - c. a processor adapted to measure said patterns;
 - d. a database comprising records of patterns' parameters characterizing predetermined materials; said database comprising records of materials that a notification should be provided when identified; and,
 - e. alerting means adapted to alert wherein the identified material is one of said predetermined group.
2. The remote XRD means according to claim 1, wherein the material is selected from at least one of the group of explosives, flammable, toxic, chemical and biological warfare substances in either solid states, spores, drugs and narcotics, radioactive agents or a combination thereof.
3. The remote XRD means according to claim 1, wherein the VOI is a metallic material.
4. The remote XRD means according to claim 1, wherein the material is being transferred on a passenger and/or in his carry-on luggage.
5. The remote XRD means according to claim 1, wherein the XRD is any technique adapted for calculating the diffraction pattern or energy profile obtained by X-ray scattering of the material.
6. The remote XRD means according to claim 5, wherein the XRD is any technique adapted for calculating the diffraction pattern or energy profile obtained by X-ray back scattering of the material.
7. The remote XRD means according to claim 1, wherein the X-ray detector is a 2D detector.

8. The remote XRD means according to claim 1, wherein the processor is adapted to measure at least a portion of the XRD patterns.
9. The remote XRD means according to claim 8, wherein the processor is adapted to measure the central portion of the XRD patterns.
10. The remote and non-intruding XRD means according to claim 1, adapted to identify moving VOIs; wherein said VOI is either carried by means of walking persons or carried on a conveyor belt, or the VOI is being moved in any way.
11. The remote and non-intruding XRD means according to claim 1, adapted to identify sampled moving VOIs; additionally comprising means to sample VOI so the presence of the VOI is notified; and means to surveillance or follow up said VOI before identifying its nature.
12. The remote XRD means according to claim 11, adapted for online surveillance or follow up.
13. The remote XRD means according to claim 1, wherein the alerting means are adapted to alert either online or offline, to alert to a predetermined remote location, to be in communication with effective means adapted to isolate or immobilize said VOI transport until subsequent notification or any combination thereof.
14. The remote XRD means according to claim 1, wherein the detector is a Cell-X; adapted for acquiring both VOI's XRD image and information about its energy profile.
15. A method for acquiring XRD image of a material in a VOI, comprising the steps of;
 - a. receiving VOI coordinates from lower stage system;
 - b. irradiating the material in the VOI;
 - c. acquiring of XRD patterns;
 - d. extracting of XRD patterns;
 - e. converting the XRD patterns (e.g. rings) of said VOI to standard powder X-ray diffraction spectrum;

- f. searching and/or matching records in a database for material identification;
and then,
 - g. alerting in case said material is in matching a predetermined record.
16. A method for acquiring XRD image of a VOI by the remote XRD means as defined in claim 1 or in any of its dependent claims, comprising the steps of
- a. receiving VOI coordinates from lower stage system;
 - b. irradiating a material in a VOI;
 - c. acquiring of XRD patterns;
 - d. extracting of XRD patterns;
 - e. converting the XRD patterns(e.g. rings) of said material to standard powder X-ray diffraction spectrum;
 - f. searching and/or matching records in a database for material identification;
and then,
 - g. alerting in case said material is in matching a predetermined record.
- wherein said XRD patterns are acquired by the remote XRD means as defined in claim 1 or any of its depended claims.
17. The method according to claims 15 or 16; wherein back-diffraction is provided.
18. The method according to claims 15 or 16 or 17; wherein the detector is a Cell-X, adapted for acquiring both VOI's XRD image and information about its energy profile.
19. The method according to claims 15 or 16 or 17; wherein the detector is a linear array, adapted for acquiring both VOI's XRD pattern position and intensity, with or without information about its energy profile.

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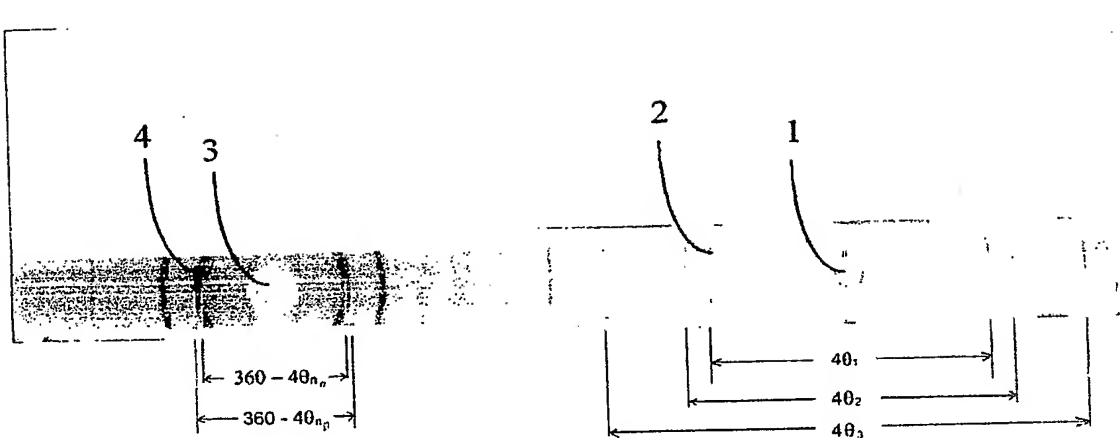


Fig. 1

2/10

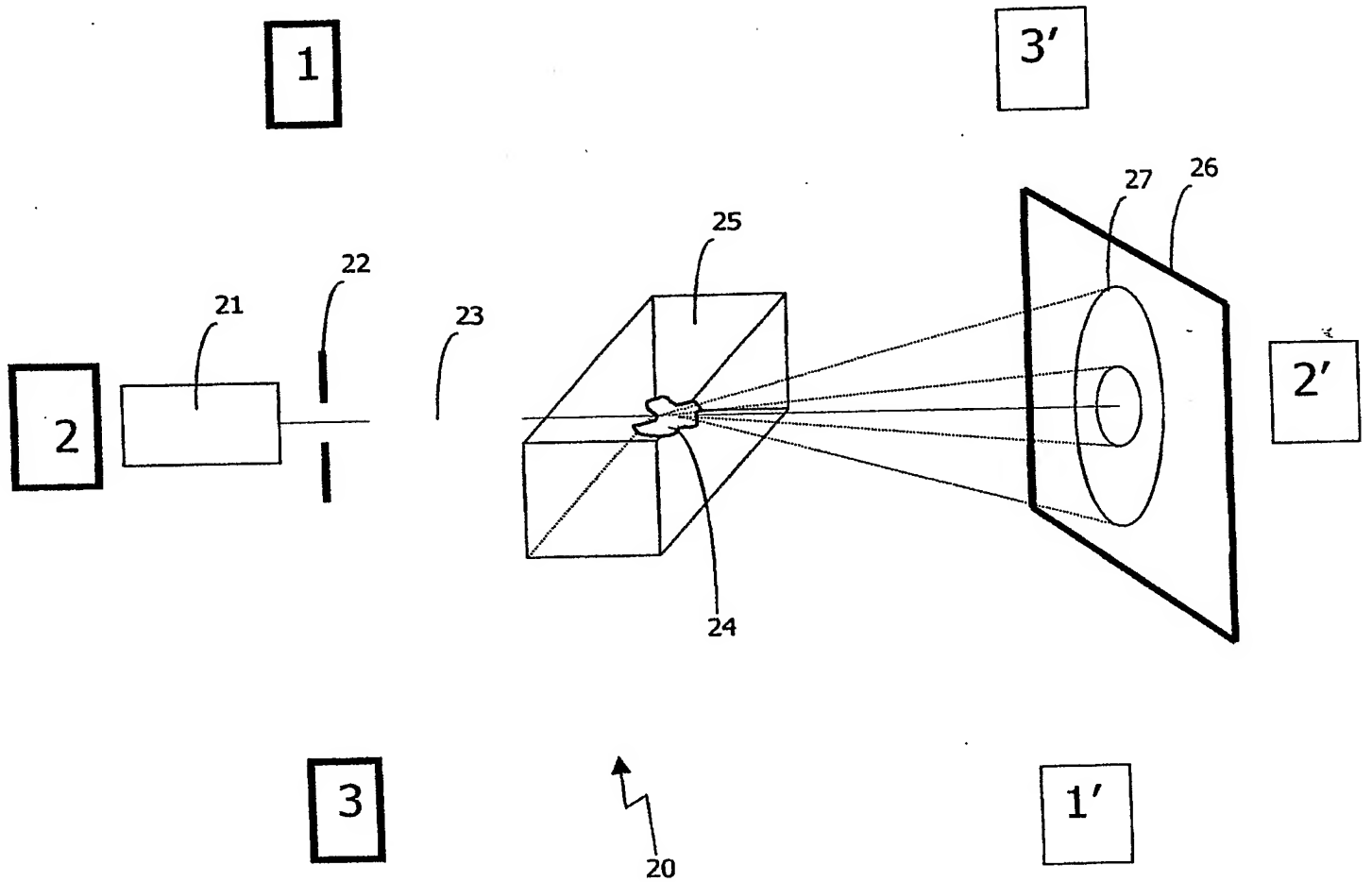


Fig. 2

3/10

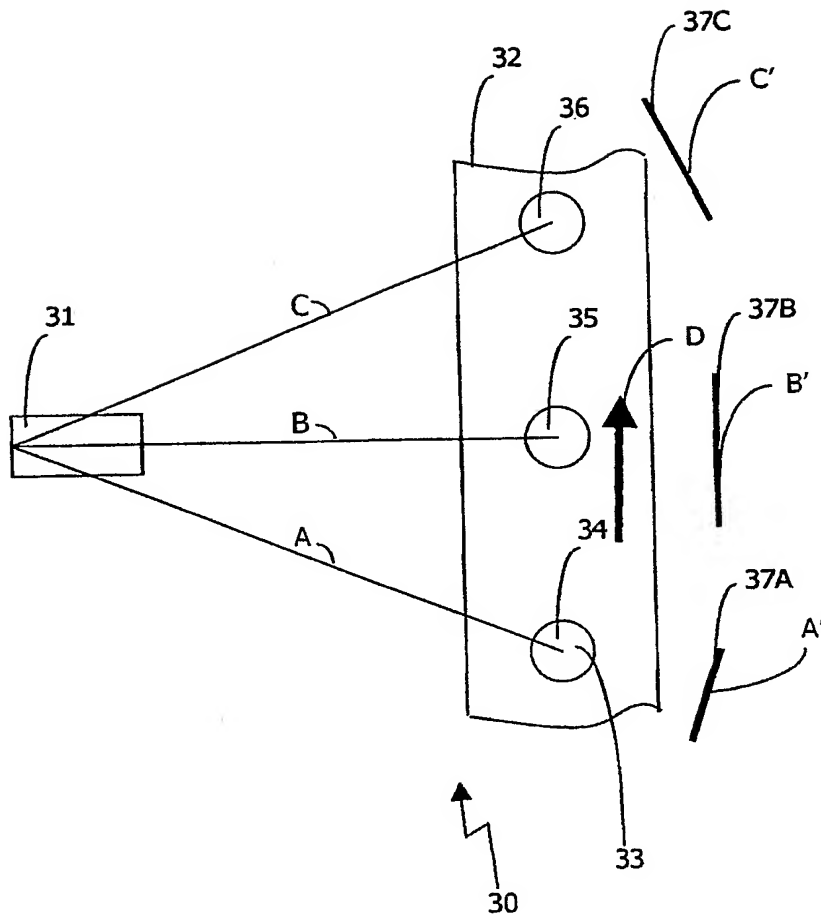


Fig. 3

4/10

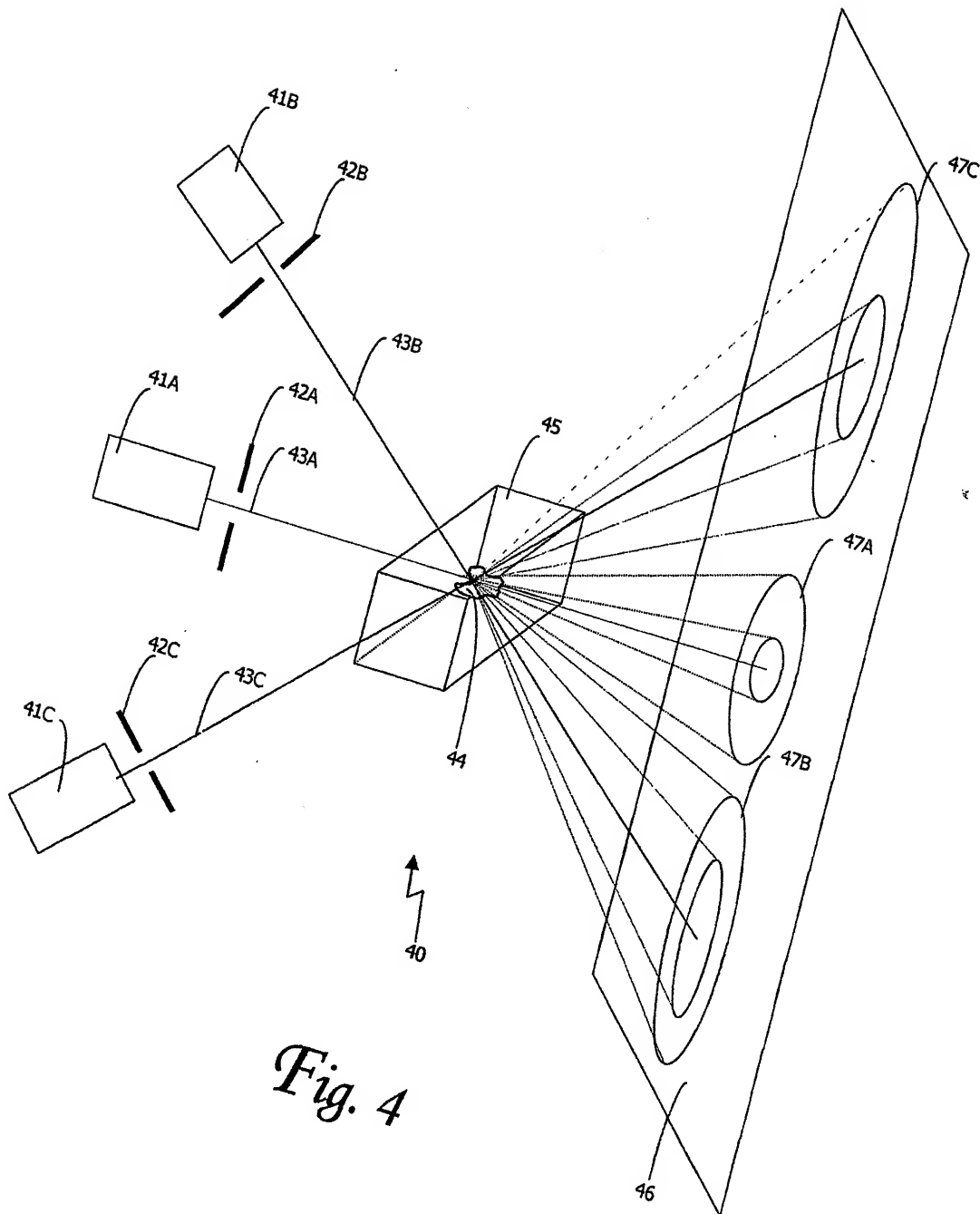


Fig. 4

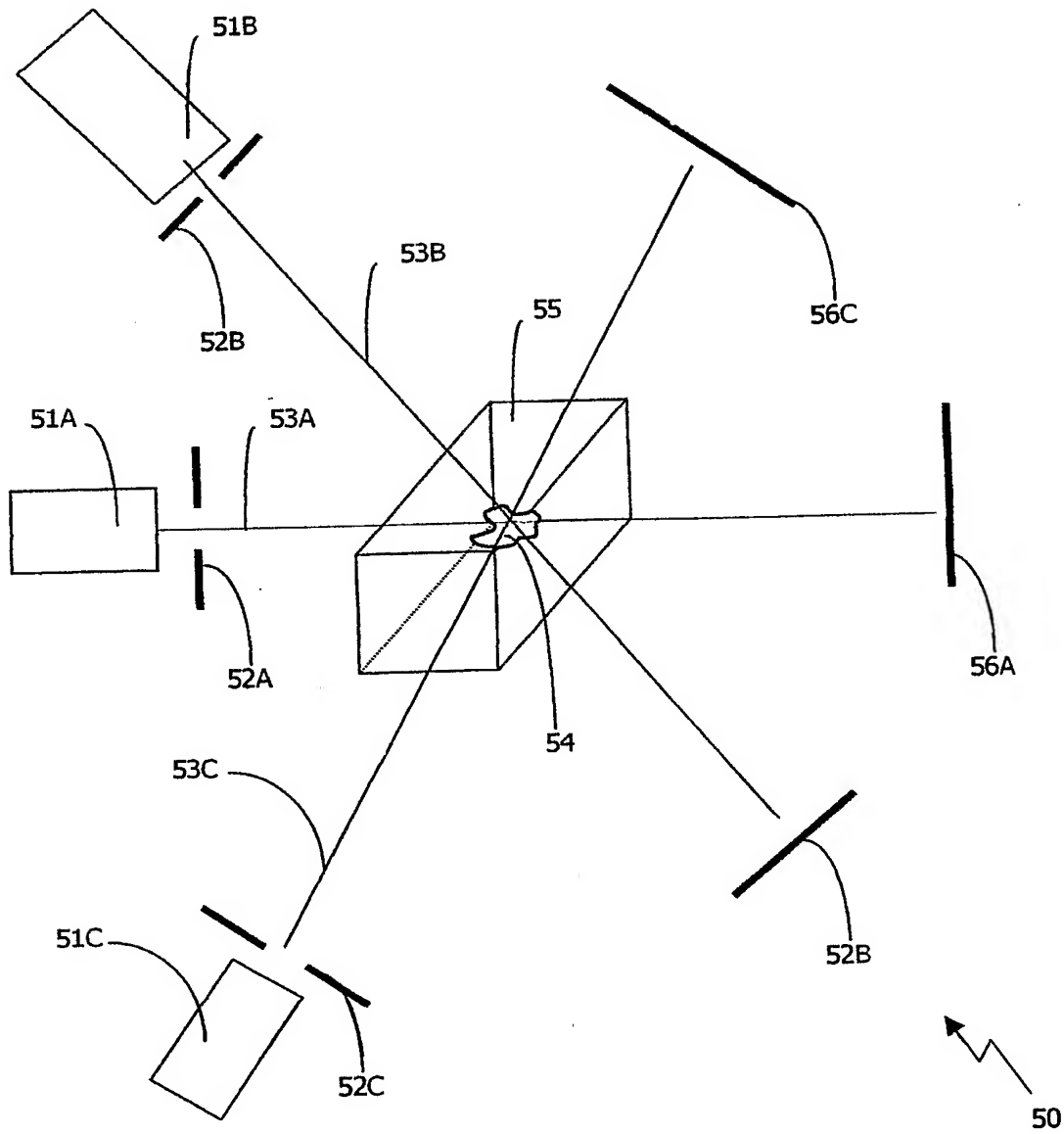


Fig. 5

6/10

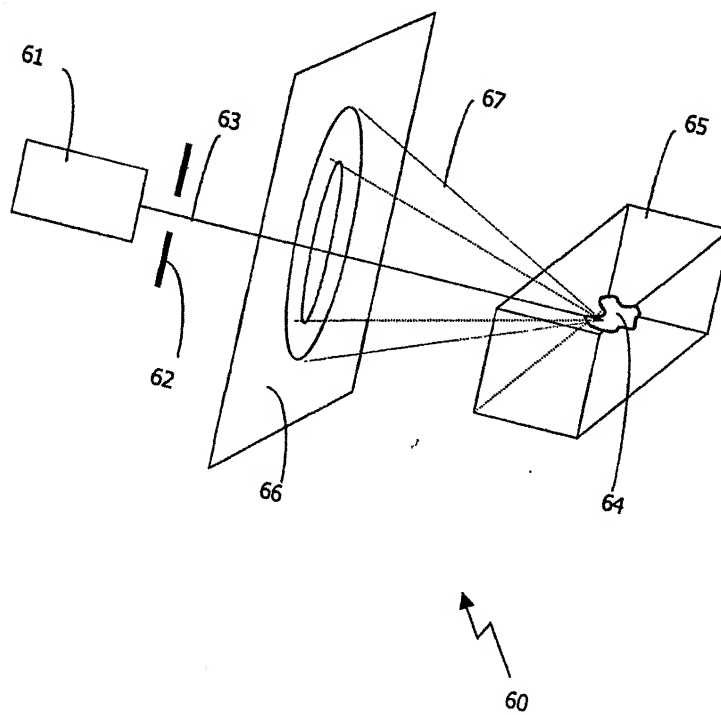


Fig. 6

7/10

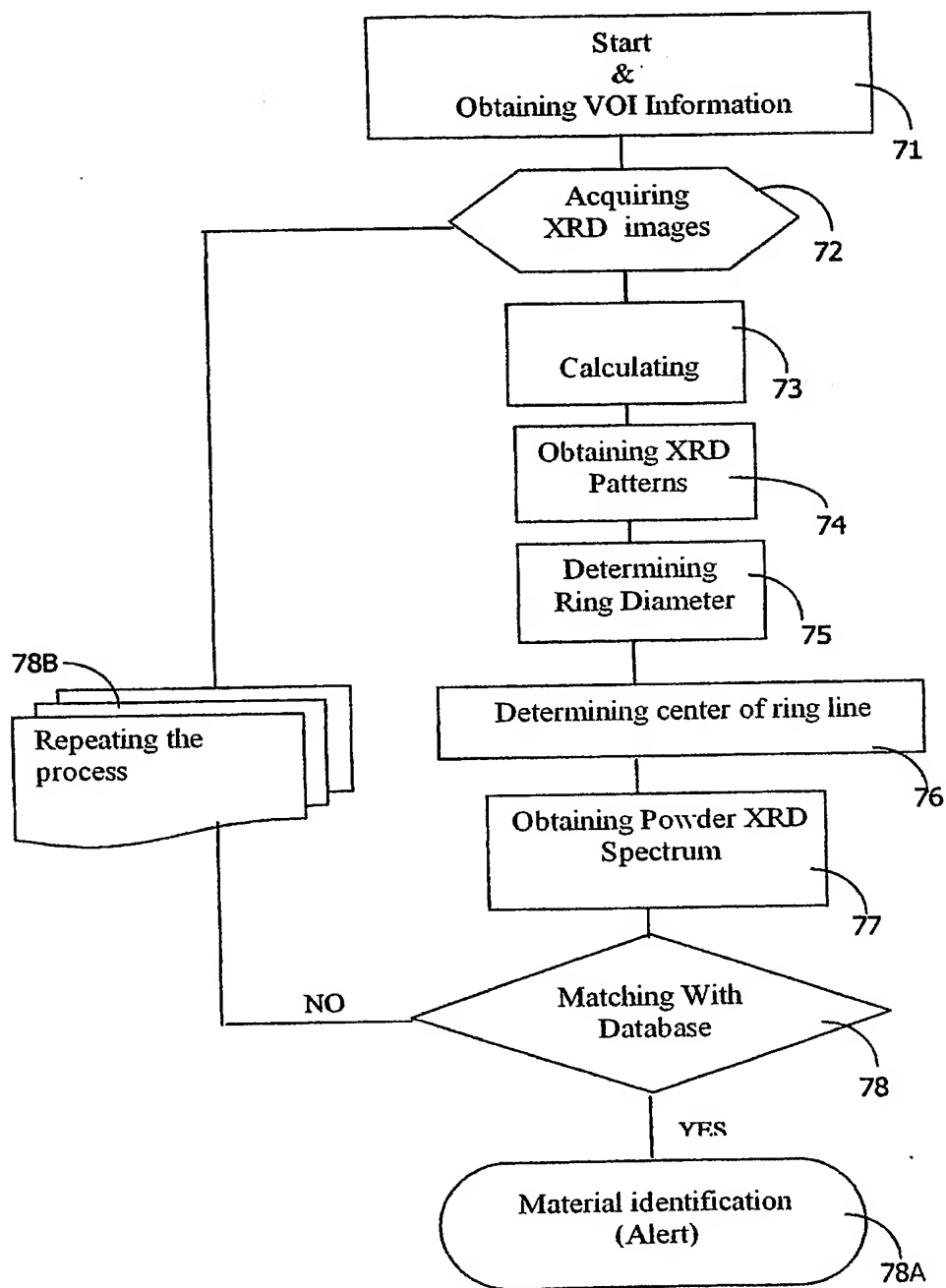
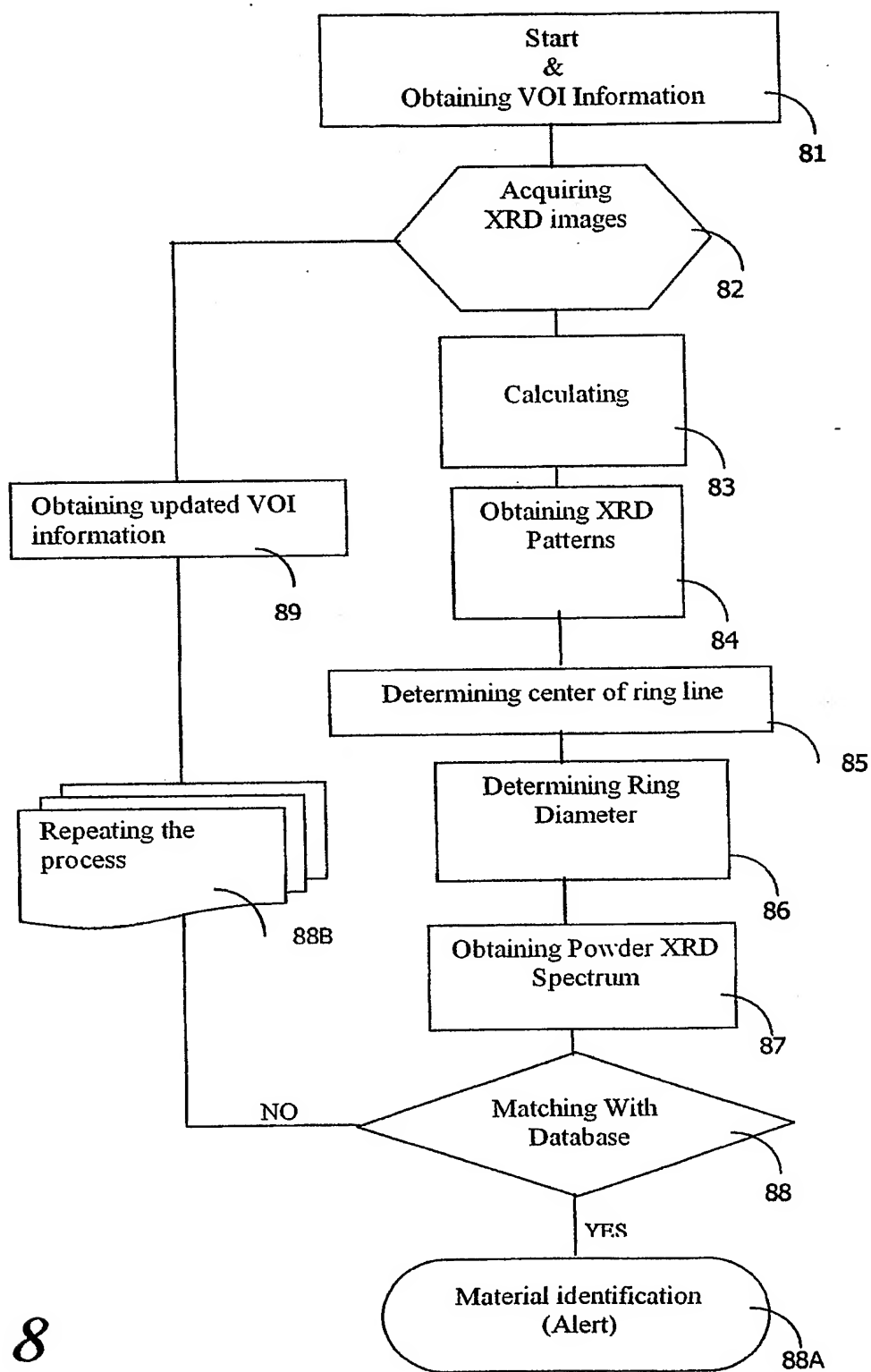
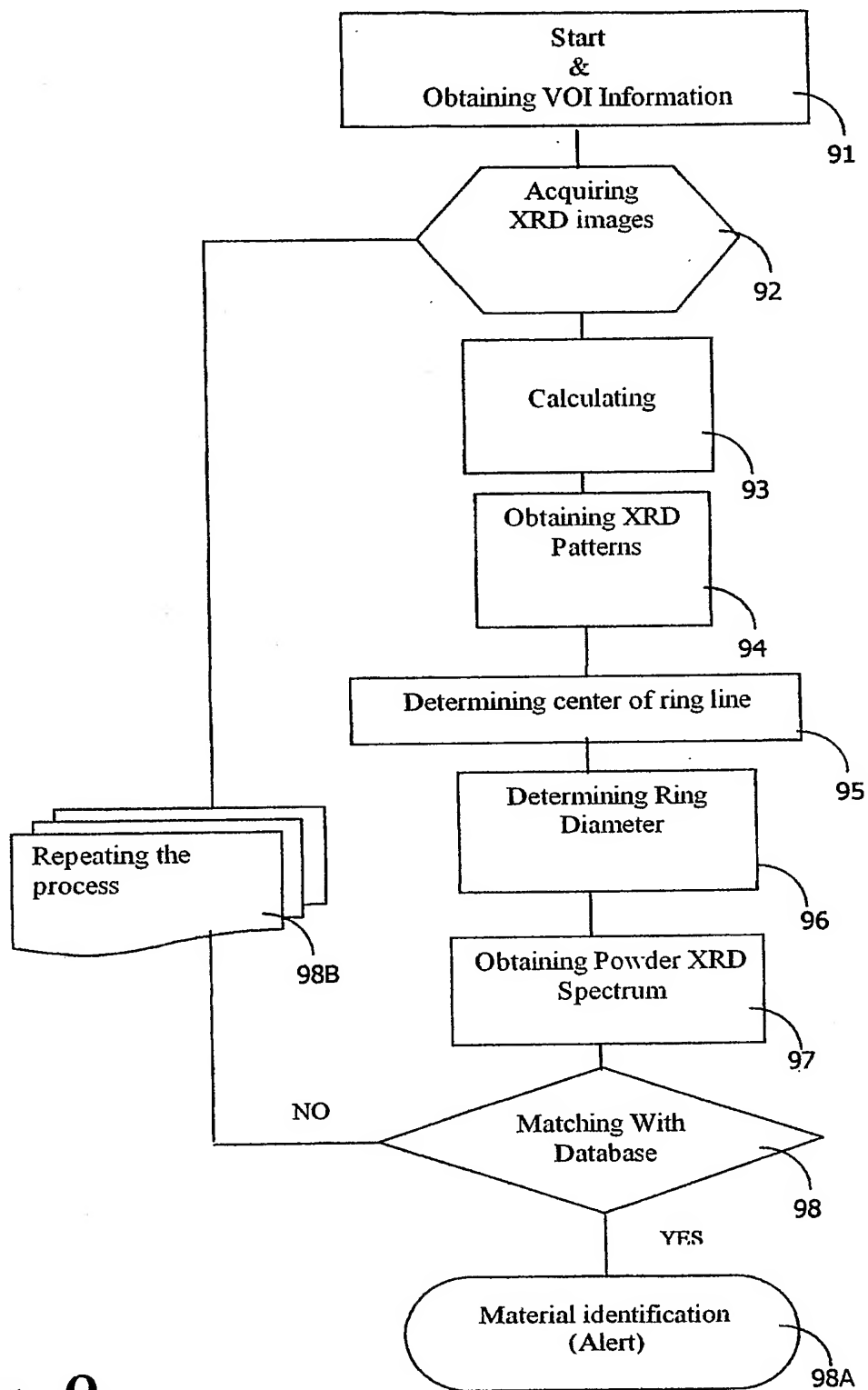


Fig. 7

*Fig. 8*

*Fig. 9*

10/10

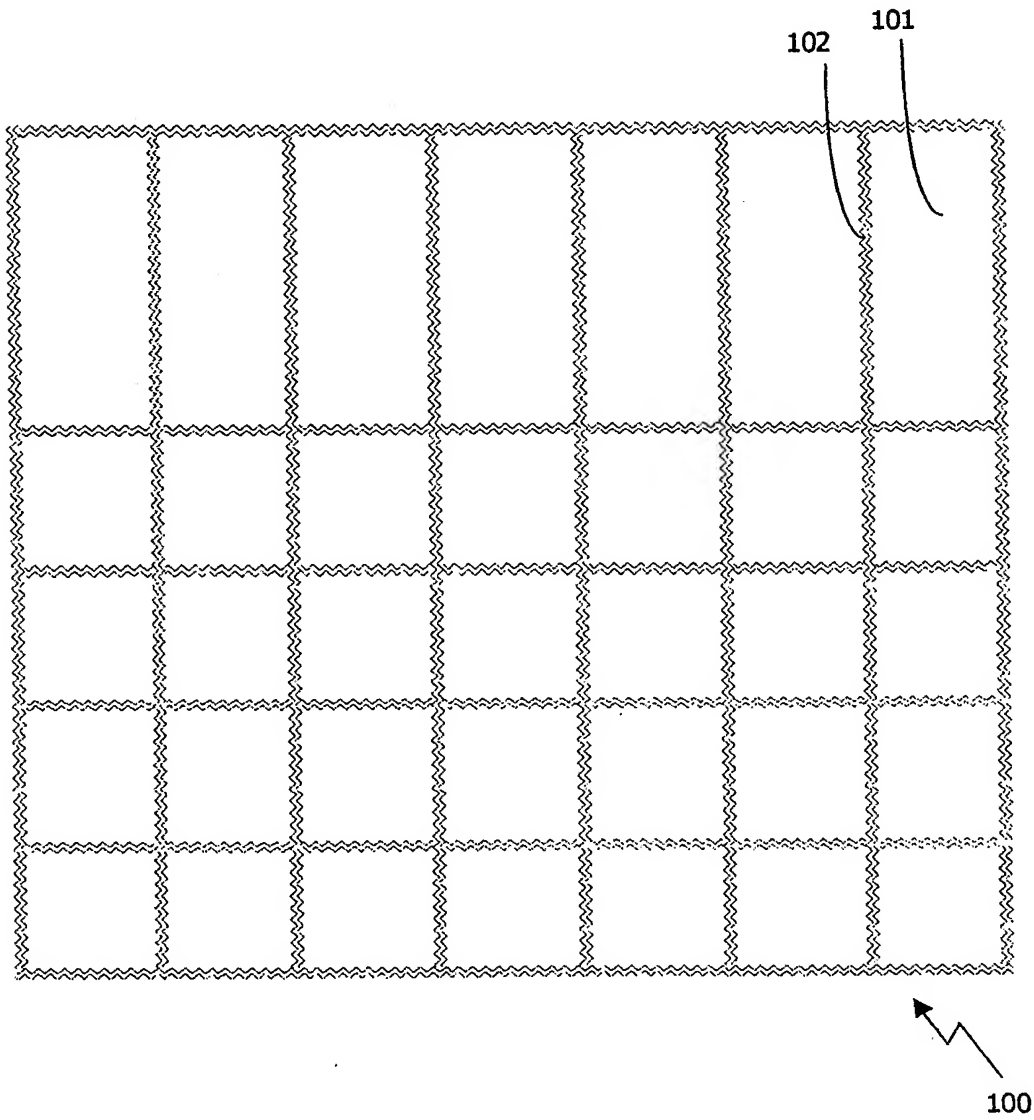


Fig. 10